IN THE CLAIMS:

The following is a list of all pending claims. Please amend the following claims as follows:

1-30 cancelled.

31. (Presently Amended) A method of underfilling a gap between a multi-sided semiconductor device and a substrate chip carrier on which it is mounted to encapsulate a plurality of electrical connections formed therebetween wherein said chip carrier is mounted on an intermediate mounting substrate, comprising:

forming a channel <u>extending through said intermediate mounting substrate and said chip</u> <u>carrier to said gap between said device and said substrate</u>; <u>and</u>

leaving said channel open to at least one side of said device to permit access to said device; and

dispensing through said channel an under-fill material into said gap adjacent said at least one side of said device through said channel.

- 32. (Original) The method of claim 31 wherein said channel permits the removal of residual flux.
- 33. (New). the method of claim 31 wherein the chip carrier has a first coefficient of thermal expansion different from a coefficient of thermal expansion of the semiconductor device.
- 34. (New). The method of claim 31 wherein the chip carrier has a first coefficient of thermal expansion different from a coefficient of thermal expansion of the intermediate mounting substrate.
- 35. (New) The method of claim 31 wherein the intermediate mounting substrate is adapted for connection to a printed circuit board, said intermediate mounting substrate having a coefficient of thermal expansion different from a coefficient of thermal expansion of the chip carrier and smaller than a coefficient of thermal expansion of the printed circuit board.

-2-